WPF40 Field Probe 20 MHz - 40 GHz



- High dynamic range of 60 dB
- Isotropic and RMS measurement
- Excellent attenuation at 50/60 Hz
- Meets international standards





Telecommunications: certification and audit of telecommunication services (GSM, 3G, LTE, TDT, FM, WiFi, etc.).



Industry: assessment of industrial processes for worker's exposure protection.



Defence: assessment of military sites and personnel exposure protection.



Labs/R&D: RF exposure protection of R&D and labs personnel.

Technical Specifications

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Frequency range	20 MHz - 40 GHz
Sensor type	Isotropic RMS diode technology
Type of frequency response	Flat
Measurement range	1 – 1000 V/m (CW) 1 – 55 V/m (RMS)
Dynamic range	60 dB
Sensitivity	1 V/m
Frequency response	± 2 dB (30 MHz - 30 GHz) + 0 / - 4 dB (30 GHz - 35 GHz) + 0 / - 6 dB (35 GHz - 40 GHz) - 3 dB @ 20 MHz
Linearity	± 2 dB (1 - 2 V/m) ± 1 dB (2 - 250 V/m)
Isotropic deviation	± 1 dB (< 12 GHz) ± 2 dB (12 GHz to 40 GHz)
Damage level (CW)	1200 V/m
Calibration	ISO 17025 accredited calibration (ILAC)
Calibration period	24 months (recommended)
Temperature range	- 20 °C to 50 °C
Temperature response	+ 0.1 / - 1 dB (related to 20 °C)
Dimensions	28.4 cm x 6 cm Ø
Weight	95 g
Attenuation at 50/60 Hz	> 40 dB

^(*) The frequency response can be corrected with the SMP2 by using the correction factors stored in the probe (ISO 17025 accredited calibration).

Compatible with SMP2, MonitEM, MapEM

Product specifications and descriptions in this document subject to change without notice



WPF40 EN 1703 v1.